

Atty. Docket No.: S16.12-0094

December 30, 1999

Applicant:

Serial No.: 09/475,721

3762

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

Reimink et al.	
Filing Date	Group Art:

U.S. PATENT DOCUMENTS

	iner tial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
<u>8H</u>	AA	5,073,171	12-17-91	John W. Eaton	604	266	
871	AB	5,304,121	04-19-94	Ronald Sahatjian	604	53	
874	AC	5,380,299	01-10-95	Fearnot et al.	604	265	
874	AD	5,383,928	01-24-95	Scott et al.	623	1	
871	AE	5,464,650	11-07-95	Berg et al.	427	2.30	
874	AF	5,545,208	08-13-96	Wolff et al.	623	1	
874	AG	5,578,075	11-26-96	Michael P. Dayton	623	1	
874	AH	5,591,227	01-07-97	Dinh et al.	623	1	
PH	AI "	5,609,631	03-11-97	Rubens et al.	623	11	
PH	AJ	5,693,085	12-02-97	Buirge et al.	623	1	
M	AK	5,693,098	12-02-97	Rubens et al.	623	11	

FOREIGN PATENT DOCUMENTS

	Document No.	Date	Country	Class	Sub Class	Transla Yes	ation No
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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FORM PTO-1449	Atty. Docket No.: S16.12-0094	Serial No.: 09/475,721			
	Applicant:	Applicant: Reimink et al.			
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION	Reimink et al.				
LIST OF PATENTS AND PUBLICATIONS FOR	Filing Date	Group Art:			
	December 30, 1999	3762			

U.S. PATENT DOCUMENTS

	iner tial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
84	AA	5,738,902	04-14-98	Forrestal et al.	427	2.12	
84	AB	5,788,979	08-04-98	Alt et al.	424	426	
874	AC	5,804,263	09-08-98	Goldberg et al.	428	34.7	
874	AD	5,824,048	10-20-98	Ronald J. Tuch	623	1	
874	AE	5,837,313	11-17-98	Ding et al.	427	2.21	
874	AF	5,866,113	02-02-99	Hendriks et al.	424	78.17	
PH	AG	5,891,196	04-06-99	Lee et al.	8	94.11	
874	AH	5,891,506	04-06-99	James R. Keogh	427	2.13	
PH	AI	5,891,507	04-06-99	Swaminathan Jayaraman	427	2.25	
श्रम	AJ	5,897,911	04-27-99	Joseph P. Loeffler	427	2.25	
874	AK	5,922,393	07-13-99	Swaminathan Jayaraman	427	2.3	-

FOREIGN PATENT DOCUMENTS

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FORM PTO-1449 MODIFIED

Docket No.: 1416.04US01

Application No.: 09/475,721

INFORMATION DISCLOSURE CITATION

APPLICANT: REIMINK et al.

IN AN APPLICATION				FILING DATE: December 30, 1999 GROUP ART UNIT: 3738					
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EXAMINER	DOCUMENT NO.	0.5	IAILNID	0001	VILIVID	T	FILING	DATE IF	
INITIAL		DATE	NAME		CLASS	SUBCLASS		PRIATE	
8H	3,579,645	05/1971	J. C. Bokro	os	3	1			
M	4,822,355	04/1989	Bhuvanesh	nwar	623	2			
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84	WO 98/36784	08/1998	PCT				X		
8h	WO 99/57581	11/1999	PCT				X		
874	WO 00/32255	06/2000	PCT				X		
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	OTHER DOC	JMENTS (ir	ncluding Aut	hor, T	itle, Date, Pe	rtinent Pages,	etc.)		
94	International Se	earch Report 22.	dated 12 Jun	ne 200	1 for Internat	ional Applica	tion No.		
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